

## VE320 Intro to Semiconductor Devices

### Summer 2024 – Problem Set 5

Due: 11:59pm, July 7<sup>th</sup>

In all problems, assume the temperature is 300K and all are completely ionization.

1. Define the built-in potential voltage and describe how it maintains thermal equilibrium.
2. Consider the equation  $R_n = R_p = \frac{np - n_i^2}{\tau_{p0}(n+n') + \tau_{n0}(p+p')} \equiv R$ , where  $\tau_{p0} = \frac{1}{N_t C_p}$  and  $\tau_{n0} = \frac{1}{N_t C_n}$ . Let  $\tau_{p0} = 10^{-7}s$  and  $\tau_{n0} = 5 \times 10^{-7}s$ . Also let  $n' = p' = n_i = 10^{15}cm^{-3}$ . Assume very low injection that  $\delta n \ll n_i$ . Calculate  $R/\delta n$  for a semiconductor which is (a) n-type ( $n_0 \gg p_0$ ), (b) intrinsic ( $n_0 = p_0 = n_i$ ), and (c) p-type ( $p_0 \gg n_0$ ).
3. Consider an n-type semiconductor as shown in the figure, doped at  $N_d = 10^{16}cm^{-3}$  and with a uniform excess carrier generation rate equal to  $g' = 10^{21}cm^{-3}s^{-1}$ . Assume that  $D_p = 10cm^2/s$  and  $\tau_{p0} = 10^{-7}s$ . The electric field is zero. (a) Determine the steady-state excess minority carrier concentration versus  $x$  if the surface recombination velocity at  $x=0$  is (i)  $s=0$ , (ii)  $s=2000cm/s$ , and (iii)  $s=\infty$ . (b) Calculate the excess minority carrier concentration at  $x=0$  for (i)  $s=0$ , (ii)  $s=2000cm/s$ , and (iii)  $s=\infty$ .

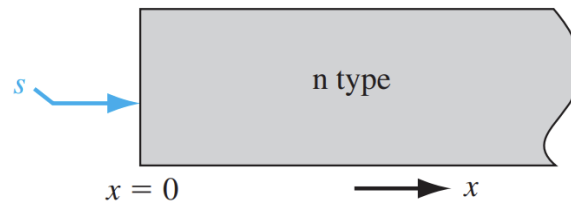


Figure 1. Diagram for problem 3

4. Consider a p1-p2 “isotype” step junction shown in the figure below:

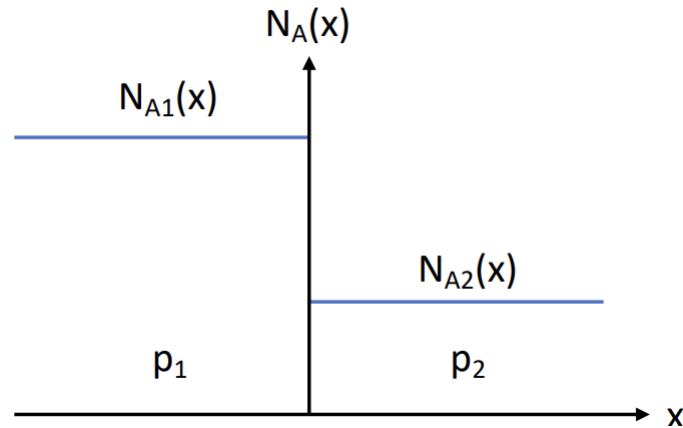


Figure 2. Diagram for problem 4

- (a) Draw the energy band diagram of the junction assuming that the doping is non-degenerate throughout. Assume an energy gap of 1.4eV.
- (b) Derive an expression for  $V_{bi}$  that exists across the junction in equilibrium.

5. A Ge diode has a p-side doping of  $N_a = 5 \times 10^{16} \text{cm}^{-3}$  and an n-side doping of half that value.

- (a) Calculate depletion widths on both sides of the junction and draw the equilibrium energy level diagram as a function of position. Carefully label all energy levels ( $E_c$ ,  $E_v$  and  $E_f$ ) and boundaries of the depletion region.
- (b) Now apply a reverse voltage 0.1V and repeat part a. Include a sketch of the approximate positions of the quasi-Fermi energies.

6. Calculate the capacitance and plot  $\frac{1}{C^2}$  vs  $V_R$  for the following Si  $n^+p$  junctions:

$$N_a = 10^{15} \text{cm}^{-3}$$

- (a) Reverse bias voltage = 1V; (b) reverse bias voltage = 5V.

(For  $n^+p$  junctions,  $N_d \gg N_a$ . Use a suitable approximation in your calculation.)

7. In the diagram below (the material is Si) :

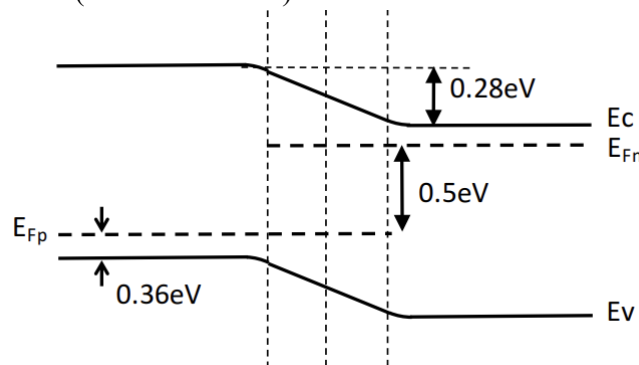


Figure 3. Diagram for problem 7

- (a) Is the diode under equilibrium or forward biased or reverse biased? If biased, what is the bias voltage?
- (b) Determine the built-in potential of the diode under equilibrium.
- (c) Determine  $N_a$  and  $N_d$ .